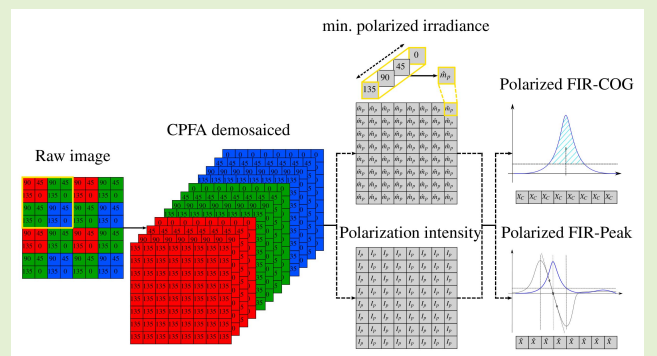


# Polarization Image Laser Line Extraction Methods for Reflective Metal Surfaces

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**Abstract**—In this work, we propose a novel pipeline method for laser line extraction from images with a polarization image sensor. The proposed method is specifically developed for strong laser beam reflections from metal surfaces. For the preprocessing stage, we propose a demosaicing algorithm for color polarizer filter array (CPFA) sensors. This can be implemented by using either one-quarter or full resolution of the sensor. In addition, we propose two methods for optimizing the information available in a 12-channel color polarization image. The first method is based on the minimum linearly polarized irradiance, and the second method is based on the linear polarization intensity. These preprocessing and optimization methods are combined with laser line extraction methods. The laser line extraction is done with either the polarized finite impulse response (FIR) center of gravity (COG), where the laser line coordinates are computed from the filtered laser intensity distribution, or with the polarized FIR-Peak, where the laser line coordinates are calculated from the first derivative of the filtered laser signal. The performance of the proposed algorithms is studied experimentally using a laser line scanner assembly, made of a polarization camera, and a laser line projector operating in the blue wavelength range.

**Index Terms**—Aluminum scanning, laser line extraction, polarization imaging, polarization sensor, reflective metal scanning, structured light sensor.



## I. INTRODUCTION

MACHINE vision systems are extensively used in various manufacturing processes [1]. Typical applications include feedback for process control, safety systems, inspections, quality control, and so on [2]. One of the most used sensor systems, for such industrial applications, is laser line scanners based on triangulation of the camera image coordinates of a projected laser line [3]. The technology is dependent on the accurate representation of the projected line geometry in the image. When laser line scanners are applied to reflective metal surfaces, laser beam reflections introduce light disturbances, which makes it difficult to accurately detect

the projected line captured by the camera image [4]. Such problems are typical for, for example, ground surfaces of welding grooves in steel [5]–[7] or aluminum [8]. Therefore, in this work, we propose and study algorithms for laser line extraction from the image of a camera with a single polarization image sensor, in the presence of noise caused by laser reflections.

Laser line scanners, which, in general, are referred to as structured light triangulation sensors, are composed of a light source, which is usually a laser projecting a beam with a known shape, in combination with a photodetector which is usually an image sensor. The two available image sensor technologies available in the market are charged couple devices (CCDs) and complementary metal–oxide–semiconductors (CMOSs), where the CMOS image sensors (CIS) is the technology that has taken over the image sensor market [9]. As a result, most of the advances done are based on CIS technology. Although there are image sensors that operate in a spectrum with either a longer [10] or a shorter [11] wavelength than visible light, the CIS technology operating in the visible spectrum is getting the most attention from the industry [12]. As an advance in the visible spectrum CIS field, a process for fabrication of a CIS with pixel-wise on-chip polarizers was presented in [13], making the broad availability of commercial off-the-shelf polarization cameras possible.

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Polarization imaging has been an active topic in the research community for decades [14]. It is normally possible by means of either rotating the polarizers manually or capturing several images simultaneously [15]. The most common imaging architecture for integrated polarimeters, which can capture several polarization images at the same time using a single image sensor, is referred to as the division of focal plane (DoFP) [16], [17]. An image sensor fabricated using the DoFP architecture is referred to as a DoFP image sensor.

The increased availability of commercial polarization CIS cameras led to increasing research efforts that focused on the process of recovering the information from a DoFP image sensor in the most accurate way, which is generally called demosaicing. The process of reconstructing the red, blue, and green channel images from a color filter array (CFA) is well known in the literature [18], and it is commonly known as Bayer demosaicing. Meanwhile, the reconstruction of the four linearly polarized images is referred to as a polarizer filter array (PFA) demosaicing. The combination of both, the CFA and PFA arrangements, is referred to as colored polarized filter array (CPFA) demosaicing. Both, PFA and CPFA demosaicing, are considered new techniques and are under active research [19]–[21].

In addition to the image sensor technology used in laser line scanners, the different methods to compute the position of the laser line in an image with subpixel accuracy is an active research topic. A commonly used method is based on intensity and is referred to as the center of gravity (COG) method, sometimes also called as the center of mass method [22]. Some other methods include an unbiased approach based on explicit models for lines [23], a finite impulse response (FIR) filtering approach [24], or convolutional neural networks [25]. An up-to-date and more in-depth review on the topic of laser line extraction can be found in [26].

As it was previously mentioned, reflections are a common problem for image sensors, in general, and laser line scanners, in particular, when images are captured on reflective metal surfaces. Several published strategies could potentially be used to minimize the reflections in a captured image by means of: a matte coat or sensor position planning [27]–[29]; stereo cameras or fringe projection [30], [31]; lens-mounted polarizer filter or color separation [4], [32]; time of flight, high dynamic range, or motion contrast sensors [33]–[35]; as well as image-based methods or machine learning [36], [37].

Although a literature review has revealed a significant amount of research on the methods and technologies for laser line scanners, the idea of using a polarization CIS that can mitigate the number of reflections at the sensor level, for the application to reflective metal surfaces, is novel. In addition, the existing approaches for reflection reduction can introduce more complexity to the sensor system.

- 1) Matte coating is not always technologically allowed, whereas sensor position planning can be physically restricted.
- 2) Stereo cameras and fringe projection can result in a bulky setup.
- 3) Polarizer and color filter mounted on the lens are additional external optical elements.

- 4) Machine learning methods require a large teaching database and a lot of computational power.

Therefore, we propose a new approach for the extraction of a laser line from a polarization CIS image. This is a continuation of our previous work in [8]. The detailed contributions in this article can be summed up as follows.

- 1) Design of a novel laser line scanner system based on a polarization CIS that is an improvement over already existing technologies, when extracting the laser line coordinates from images of reflective surfaces.
- 2) Two novel methods to minimize the noise of the measurements based on the unique capabilities of the polarization CIS: the first method is based on the minimum linearly polarized irradiance of the four linear polarization angles, and the second method is based on the linear polarization intensity, which is computed by means of the Stokes parameters.
- 3) Two novel algorithms for extracting the laser line coordinates from an image: the polarized FIR-COG method and the polarized FIR-Peak method.
- 4) The proposed methods have been developed using basic operations (e.g., downsampling and convolution), which facilitates implementing the entire pipeline on an industrial embedded system.

The rest of this article is organized as follows. Section II shortly presents the preliminaries of this work. Section III introduces the proposed polarized vision system, whereas Sections IV and V present the proposed algorithms for pre-processing and optimization of color polarized image data, respectively. Laser line extraction algorithms for polarized images are given in Section VI. Section VII presents the experimental study results and discussion, whereas Section VIII draws conclusions of this work.

## II. PRELIMINARIES

### A. Polarization of Light

Light exhibits a vectorial nature that can be described by polarization. The equation of the polarization ellipse can be expressed in terms of the four Stokes parameters  $S_0$ ,  $S_1$ ,  $S_2$ , and  $S_3$  [38]. The Stokes parameter  $S_0$  is the total irradiance,  $S_1$  denotes the preponderance of horizontal polarization over vertical polarization,  $S_2$  denotes the preponderance of 45° polarization over 135° polarization, and  $S_3$  denotes the preponderance of the right over the left circularly polarized flux. An important property is that for any state of polarized light, the Stokes parameters satisfy the condition

$$S_0^2 \geq S_1^2 + S_2^2 + S_3^2. \quad (1)$$

The angle of polarization  $\Psi$  (or AoP) can be expressed by the Stokes parameters as

$$\Psi = \frac{1}{2} \arctan \frac{S_2}{S_1} \quad (2)$$

and the degree of polarization (DoP) can be expressed as

$$\text{DoP} = \frac{I_{\text{pol}}}{I_{\text{tot}}} = \frac{\sqrt{S_1^2 + S_2^2 + S_3^2}}{S_0} \quad (3)$$

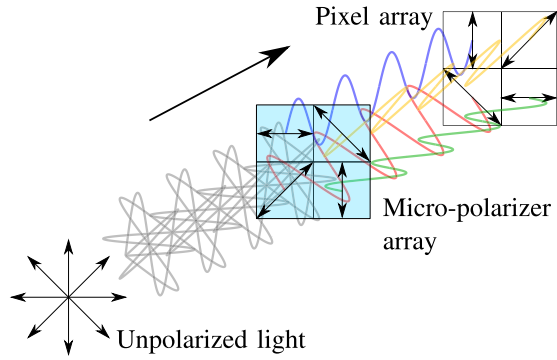


Fig. 1. Arrangement of the wire grid polarizer and pixel arrays.

where  $0 \leq \text{DoP} \leq 1$ ,  $I_{\text{tot}}$  is the total intensity, and  $I_{\text{pol}}$  is the total polarization intensity.

For more details on the theory of polarization, the reader is referred to [39].

### B. Polarization Image Sensor

Traditional image sensors can measure the oscillations of light waves as a scalar. In order to measure the four Stokes parameters ( $S_0$ ,  $S_1$ ,  $S_2$ , and  $S_3$ ), a full Stokes polarization camera [40] would ideally have to be used. This is due to the necessity of acquiring the four linearly polarized images ( $I_0$ ,  $I_{45}$ ,  $I_{90}$ , and  $I_{135}$ ), plus the two circularly polarized images ( $I_L$  and  $I_R$ ) for the left and right circular polarization, respectively. Then, the Stokes parameters can be determined as

$$\begin{aligned} S_0 &= I_0 + I_{90}, & S_1 &= I_0 - I_{90} \\ S_2 &= I_{45} - I_{135}, & S_3 &= I_R - I_L. \end{aligned} \quad (4)$$

The Stokes parameters (4) can also be expressed as the Stokes vector  $\mathbf{S} = [S_0 \ S_1 \ S_2 \ S_3]^T$ .

The architecture of the polarization CIS used in this work [13] is designed with four linear polarizers at four different angles, whereas the two circular polarizers are missing on the hardware side. This configuration is often referred to as a Linear Stokes Polarization camera [41]. For this case, the Stokes vector is  $\mathbf{S} = [S_0 \ S_1 \ S_2]^T$ . Then, DoP as defined in (3) is referred to as the degree of linear polarization DoLP, which is defined as

$$\text{DoLP} = \frac{I_{L\text{pol}}}{I_{\text{tot}}} = \frac{\sqrt{S_1^2 + S_2^2}}{S_0} \quad (5)$$

where  $I_{L\text{pol}}$  is the linear polarization intensity.

The polarizers used in such a polarization CIS are called wired grid polarizers, and they block (by reflection) the polarization parallel to the wire direction, whereas they transmit the polarization normal to the wire direction [13]. A representation of these polarizers can be seen in Fig. 1.

### C. Image Preprocessing

1) *Irradiance*: In this work, an image is a 2-D intensity or irradiance array. It is a map  $I$ , defined as a compact 2-D rectangular region  $\Omega$  occupied by the image sensor, taking

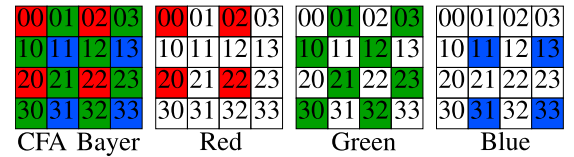


Fig. 2. Color filter array subsampled channels.

values within the positive real numbers. So,  $I$  can be written as the function [42]

$$I : \Omega \subset \mathbb{R}^2 \rightarrow \mathbb{R}_+; \quad (x, y) \mapsto I(x, y). \quad (6)$$

For the digital image sensor used in this work,  $\Omega = [1, 2056] \times [1, 2464] \subset \mathbb{Z}^2$ , and  $\mathbb{R}_+$  of the digitized image is an interval of integers  $[0, 255] \subset \mathbb{Z}_+$ .

2) *Convolution*: The convolution of a kernel  $F$  of size  $m \times n$  with an image  $I(x, y)$ , denoted by  $(F * I)(x, y)$  is defined [43] as

$$(F * I)(x, y) = \sum_{s=-a}^a \sum_{t=-b}^b F(s, t) I(x - s, y - t) \quad (7)$$

where the minus signs align the coordinates of  $I$  and  $F$ , when one of the functions is rotated by  $180^\circ$ . In this article, a  $*$  symbol is a convolution operator.

3) *CFA Demosaicing*: The value of the missing pixels, for each of the three color subsampled images of a color sensor using a Bayer filter pattern, can be estimated by bilinear interpolation [18]. If a  $4 \times 4$  pixels area of the sensor and the subsampled red color channel image are taken as an example, as shown in Fig. 2, it can be stated that

$$\begin{aligned} \hat{I}^R(1, 1) &= \frac{1}{4}[I^R(0, 0) + I^R(2, 0) + I^R(0, 2) + I^R(2, 2)], \\ \hat{I}^R(0, 1) &= \frac{1}{2}[I^R(0, 0) + I^R(0, 2)]. \end{aligned} \quad (8)$$

Then, it can be inferred that an estimation of every color channel image can be compactly expressed by convolution as

$$\begin{aligned} \hat{I}^R(x, y) &= (F^{R,B} * I^R)(x, y), \\ \hat{I}^G(x, y) &= (F^G * I^G)(x, y), \\ \hat{I}^B(x, y) &= (F^{R,B} * I^B)(x, y) \end{aligned} \quad (9)$$

with the kernels

$$F^{R,B} = \begin{bmatrix} 1 & 2 & 1 \\ 2 & 4 & 2 \\ 1 & 2 & 1 \end{bmatrix} \cdot \frac{1}{4}, \quad F^G = \begin{bmatrix} 0 & 1 & 0 \\ 1 & 4 & 1 \\ 0 & 1 & 0 \end{bmatrix} \cdot \frac{1}{4}. \quad (10)$$

4) *PFA Demosaicing*: The value of the missing pixels, for each of the four polarization angle subsampled channel images captured by a DoFP sensor, can be estimated by applying a filter adapted from the pseudo-panchromatic image (PPI) [19]. If a  $4 \times 4$  pixels area of the DoFP sensor and the subsampled  $90^\circ$  of polarization channel images are taken as an example, as shown in Fig. 3, it can be stated that

$$\begin{aligned} \hat{I}_{90}(1, 1) &= \frac{1}{4}[I_{90}(0, 0) + I_{90}(2, 0) + I_{90}(0, 2) + I_{90}(2, 2)] \\ \hat{I}_{90}(0, 1) &= \frac{1}{2}[I_{90}(0, 0) + I_{90}(0, 2)]. \end{aligned} \quad (11)$$

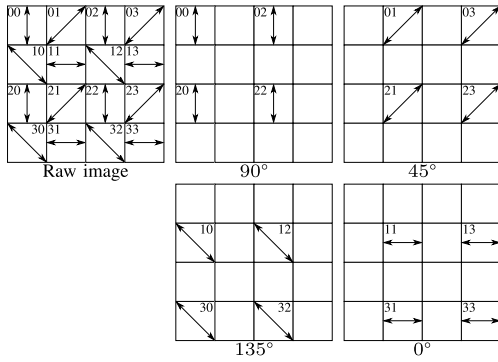


Fig. 3. Micro-polarizer filter array subsampled channels.

Then, it can be inferred that the estimation of every polarization channel image can be compactly expressed by convolution as

$$\hat{I}_a(x, y) = (F_{\text{PPI}} * I_a)(x, y), \quad a \in \{0, 45, 90, 135\} \quad (12)$$

with the kernel

$$F_{\text{PPI}} = \begin{bmatrix} 1 & 2 & 1 \\ 2 & 4 & 2 \\ 1 & 2 & 1 \end{bmatrix} \cdot \frac{1}{16} \quad (13)$$

which is normalized, so that the sum of all its elements is equal to 1 [44].

#### D. Image Processing

1) *Color to Grayscale Conversion*: From the many different methods for converting an RGB image to grayscale [45], in this work, a standard method based on luminance was used [46]. An equivalent grayscale of a color image can be computed by the weighted combination of its RGB color channels as

$$I^{\text{gray}}(x, y) = 0.3I^R(x, y) + 0.59I^G(x, y) + 0.11I^B(x, y). \quad (14)$$

2) *Savitzky–Golay Filters*: S–G filters are commonly used for smoothing the data captured from a noisy measured signal [47]. In this work, S–G filters are used to compute the smoothed  $I_s$ , and first derivative  $I_d$  images of the laser, before performing the laser line extraction algorithms. The S–G smoothing  $F_s$ , and first derivative  $F_d$  filters use the least-squares polynomial approximation [48] and utilizes a simple convolution operation

$$I_s(x, y) = (F_s * I)(x, y), \quad I_d(x, y) = (F_d * I)(x, y). \quad (15)$$

For implementing the S–G smoothing and first derivative filters, the coefficients from [49] were used.

3) *Center of Gravity Method*: The COG method is one of the most common methods for extracting the laser line coordinates from an image [50]. It is based on the computation of the COG with subpixel precision by means of the sum of intensities  $I_\Sigma$ ,

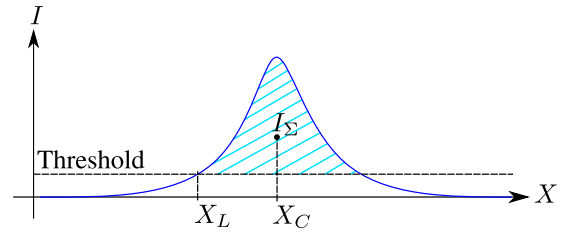


Fig. 4. Center of Gravity method diagram.

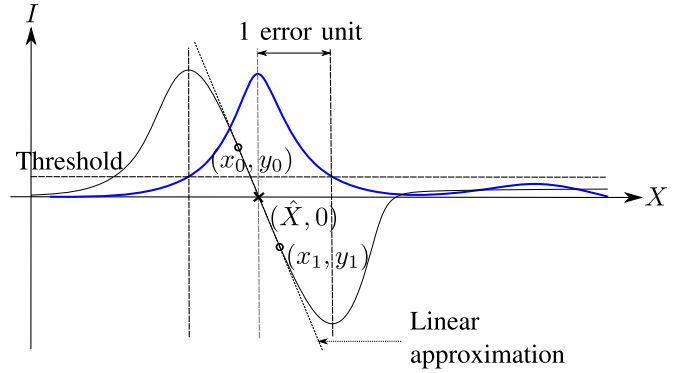


Fig. 5. FIR-Peak method diagram (based on [24]).

and the sum of the first-order moments  $M_\Sigma$

$$X_{C_j} = X_L + \frac{M_\Sigma}{I_\Sigma} = X_L + \frac{\sum_{i=1}^N x_i I(x_i, y_j)}{\sum_{i=1}^N I(x_i, y_j)} \quad (16)$$

$$Y_{C_j} = y_j$$

where  $N$  is the number of pixels of the profile, and  $X_L$  is the left edge of the laser profile (see Fig. 4).

4) *FIR-Peak Method*: The main property behind the FIR filter approach [24] is that the first derivative of the convolution of a signal with a filter is equivalent to the convolution of a signal with the first derivative of the filter

$$I_d(n) = \frac{d}{dn}[I(n) * F(n)] = I(n) * \frac{dF(n)}{dn} = (I * F_d)(n) \quad (17)$$

where  $I(n)$  is the laser signal in the row,  $F(n)$  is the coefficients of the filter,  $I_d(n)$  is the first derivative of the filtered laser signal row, and  $F_d$  is the coefficients of the first derivative filter.

The method consists of finding the laser signal maximum value, then finding the first negative value, and compute a line between the last positive  $(x_0, y_0)$  and the first negative  $(x_1, y_1)$  values. This procedure is represented in Fig. 5, and can be summed up in the following expression:

$$\hat{X} = x_0 - \frac{y_0 \cdot (x_1 - x_0)}{y_1 - y_0} \quad (18)$$

where  $\hat{X}$  is the estimated position of the zero-crossing.

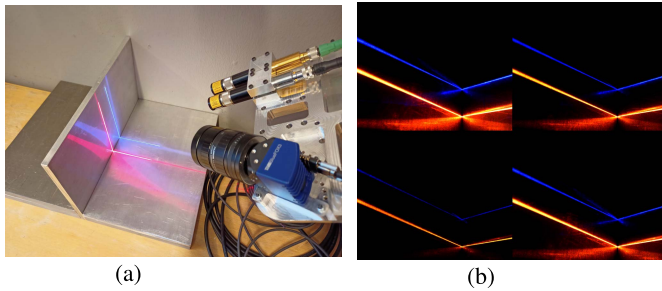


Fig. 6. Comparison of the polarization camera images for the red (640 nm) and blue (450 nm) lasers. (a) Physical setup for image acquisition. (b) Acquired images for different polarization angles.

### III. PROPOSED POLARIZATION VISION SYSTEM

In this work, we propose a polarization vision system, which can be used for scanning, and inspection of surfaces made of highly reflective metals like aluminum. The system includes the data processing pipeline, which goes from the acquisition of the raw polarization image produced by the polarization CIS, to extracting the laser line coordinates with subpixel precision from the optimized polarization image.

The proposed polarization vision system can be implemented using commercial off-the-shelf components: an industrial polarization CIS camera (color or monochrome capable), a generic C-mount lens, a laser line projector, and an embedded platform to compute the algorithms. The CIS is assumed to be a DoFP polarization CIS, which is implemented in a generic industrial camera (i.e., GenICam). Such cameras often integrate a firmware that usually runs on an embedded FPGA, which takes care of the lower level preprocessing part, such as defective pixels, and dark current corrections, or adjusting the shutter speed. The laser line projector is assumed to be operating in the visible spectrum and projecting a homogeneous line (i.e., the same light intensity along the line).

In our preliminary tests, when designing the polarized vision system, a red laser operating at 640 nm was used as a reference. As it is broadly used in the industry, it was previously used in [8]. In order to minimize the noise introduced in the vision system, a blue version of the laser operating at 450 nm was chosen, because of the reduced speckles interference [51], due to its shorter wavelength. Hence, making this laser more suitable for the specific purpose of scanning very reflective metals (e.g., aluminum alloy 6082). An experimental comparison of both lasers revealed that the blue laser displays a smaller amount of reflections for the four polarization angle images captured by the CIS (see Fig. 6). In the proposed system, we aim to use an affordable machine vision laser line projector. Thus, some optical specifications are not given by the technical datasheets and cannot be used as input to the proposed algorithm (e.g., Stokes vector values).

The polarization vision system imaging methods presented in this work are divided into three groups (see Fig. 7), depending on the image processing stage: preprocessing, optimization, and processing. In the preprocessing stage, the raw polarization image is demosaiced to a 12-channel color polarization image. In the optimization stage, the 12-channel

### Algorithm 1 Quarter Resolution CPFA Demosaicing (PolarDemQR)

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**Input:** Polarization image sensor raw image  $I_{\text{raw}}(x_{\text{raw}}, y_{\text{raw}})$   
**Output:** 12 channels quarter res. polarization image  $\hat{I}_a^c(\frac{x_{\text{raw}}}{2}, \frac{y_{\text{raw}}}{2})$   
 $a \in \{0, 45, 90, 135\}$ ,  $c \in \{\text{Red, Green, Blue}\}$

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1: procedure POLARDEMQR( $I_{\text{raw}}(x_{\text{raw}}, y_{\text{raw}})$ )
2:    $x \leftarrow \frac{x_{\text{raw}}}{2}$  ▷ Half of the raw image rows
3:    $y \leftarrow \frac{y_{\text{raw}}}{2}$  ▷ Half of the raw image columns
4:   for every pixel in  $x$  row do ▷ Sub and downsampling
5:     for every pixel in  $y$  column do ▷ from 1 to 4 channels
6:        $I_{90}(x, y) \leftarrow I_{\text{raw}}(2x, 2y)$ 
7:        $I_{45}(x, y) \leftarrow I_{\text{raw}}(2x, 2y + 1)$ 
8:        $I_0(x, y) \leftarrow I_{\text{raw}}(2x + 1, 2y + 1)$ 
9:        $I_{135}(x, y) \leftarrow I_{\text{raw}}(2x + 1, 2y)$ 
10:    for every  $\{0, 45, 90, 135\}$  in  $a$  do ▷ RRGB subsampling
11:      for every pixel in  $x/2$  row do ▷ from 4 to 12 channels
12:        for every pixel in  $y/2$  column do
13:           $\hat{I}_a^R(2x, 2y) \leftarrow I_a(2x, 2y)$  ▷ Red
14:           $\hat{I}_a^G(2x + 1, 2y) \leftarrow I_a(2x + 1, 2y)$  ▷ Green
15:           $\hat{I}_a^G(2x, 2y + 1) \leftarrow I_a(2x, 2y + 1)$  ▷ Green
16:           $\hat{I}_a^B(2x + 1, 2y + 1) \leftarrow I_a(2x + 1, 2y + 1)$  ▷ Blue
17:    for Every  $\{0, 45, 90, 135\}$  in  $a$  do ▷ Color data est.
18:      for Every  $\{\text{Red, Green, Blue}\}$  in  $c$  do
19:         $\hat{I}_a^c(x, y) \leftarrow F^c(s, t) * \hat{I}_a^c(x, y)$  ▷ Convolution
20:    return  $\hat{I}_a^c(x, y)$  ▷ Output is a 12 channels polarization im.

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polarization image is converted into a single-channel image, exploiting the special capabilities of the polarization CIS. In the processing stage, the position of the laser line is extracted with subpixel precision.

The methods were specifically developed to be easy to pipeline, so that the output of each stage can become the input for the next stage. As a result, eight different image processing pipelines can be implemented, based on the combination of the two preprocessing methods, the two optimization methods, and the two processing methods. All the methods were developed to avoid computational expensive operations whenever possible, by means of using basic operations (e.g., subsampling and convolution), in a way that a pipeline implemented using the proposed methods can run on an embedded system.

### IV. COLOR POLARIZATION IMAGE PREPROCESSING

In this section, we propose two demosaicing methods to reconstruct the 12 channels from a CPFA sensor raw image, which combines both, a CFA and a PFA, in a single CIS. The methods are developed in a general manner but are specifically adapted to the Sony IMX250MYR sensor (see Section VII-A). The IMX250MYR uses the PFA arrangement in Fig. 3, but it does not follow the standard Bayer pattern in Fig. 2. It uses a quad Bayer coding (QBC) [52], for the arrangement of its CFA elements instead. Then, the superpixel array configuration for the raw image can be obtained by adding the PFA to the QBC arrangement (see Fig. 7).

#### A. Quarter Resolution CPFA Demosaicing

The strategy for performing the CPFA demosaicing of the raw image is summarized in Fig. 8. In the first step, four subsampled images are created: one for each linear polarization angle ( $0^\circ$ ,  $45^\circ$ ,  $90^\circ$ , and  $135^\circ$ ). Then, the four images

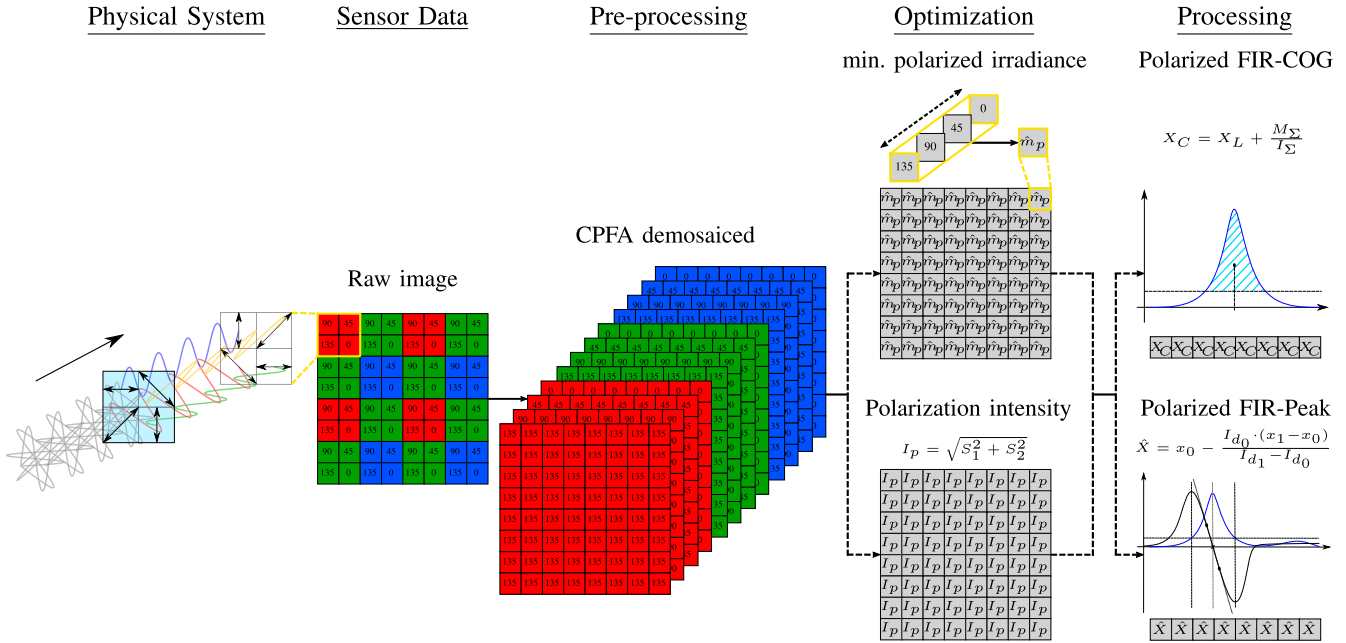


Fig. 7. Overview of the polarization vision system.

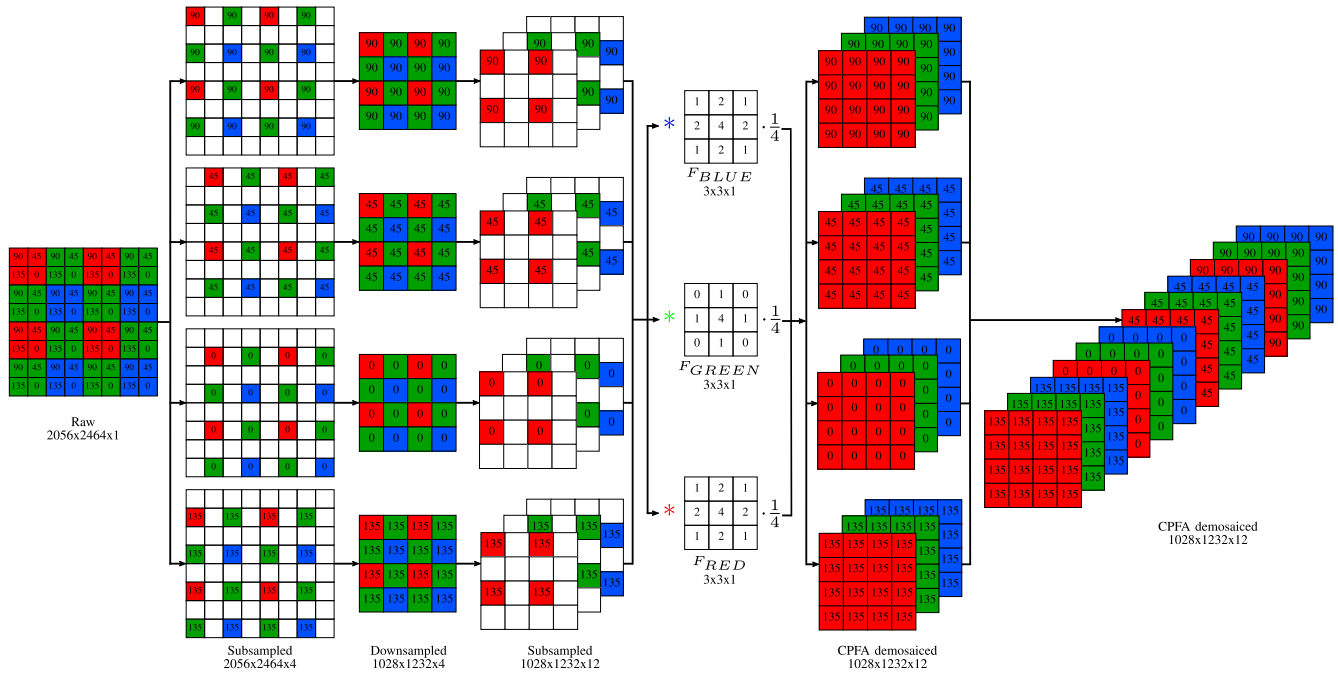


Fig. 8. Quarter resolution CPFA demosaicing.

are downsampled, reducing both, the vertical and horizontal resolution, by a factor of 2, resulting in images that are one-quarter of their original resolution. At this point, the PFA demosaicing part of the process is done, as the outcome is four lower resolution color images in the Bayer pattern. After that, the CFA demosaicing part of the CPFA process starts (similarly as in Section II-C.3), where each of the four subsampled and downsampled images is subsampled again. But this time, three subsampled images are generated for each of the four linear polarization angles, and one for each color channel (red, green, and blue), creating a 12-image

array as an outcome. Then, a convolution operation is applied for each of the 12 channels with the corresponding kernel (10), for each color channel. As a result, a 12-channel CPFA demosaiced image, with one-quarter of the original raw image resolution is generated.

### B. Full Resolution CPFA Demosaicing

The one-quarter resolution image results obtained by the procedure shown in Fig. 8 can readily be used in further stages of the pipeline. Although for the cases where the full original resolution is required, we propose the extension of the method

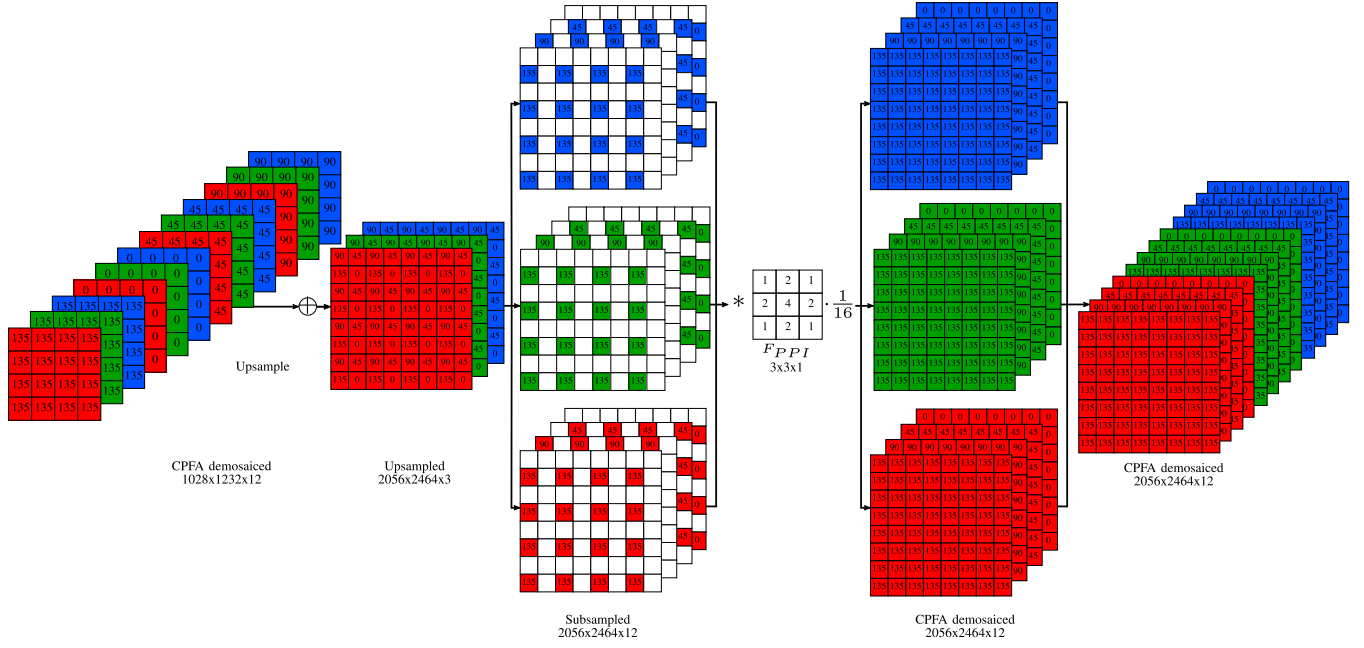


Fig. 9. Full-resolution CPFA demosaicing.

### Algorithm 2 Full Resolution CPFA Demosaicing (PolarDemFR)

**Input:** 12-channel quarter resolution polarization image  $\hat{I}_a^c(x, y)$   
**Output:** 12-channel full-resolution polarization image  $\hat{I}_a^c(2x, 2y)$ ,  
 $a \in \{0, 45, 90, 135\}$ ,  $c \in \{\text{Red, Green, Blue}\}$

- 1: **procedure** POLARDEMFR( $\hat{I}_a^c(x, y)$ )
- 2: **for** every {Red, Green, Blue} **in**  $c$  **do** ▷ Upsampling
- 3:   **for** every pixel **in**  $x$  row **do** ▷ from 12 to 4 channels
- 4:     **for** every pixel **in**  $y$  column **do**
- 5:        $\bar{I}^c(2x, 2y) \leftarrow \hat{I}_{90}^c(x, y)$
- 6:        $\bar{I}^c(2x, 2y + 1) \leftarrow \hat{I}_{45}^c(x, y)$
- 7:        $\bar{I}^c(2x + 1, 2y + 1) \leftarrow \hat{I}_0^c(x, y)$
- 8:        $\bar{I}^c(2x + 1, 2y) \leftarrow \hat{I}_{135}^c(x, y)$
- 9:   **for** every {Red, Green, Blue} **in**  $c$  **do** ▷ Subsampling
- 10:     **for** every pixel **in**  $x$  row **do** ▷ from 4 to 12 channels
- 11:      **for** every pixel **in**  $y$  column **do**
- 12:        $\bar{I}_{90}^c(2x, 2y) \leftarrow \bar{I}^c(2x, 2y)$
- 13:        $\bar{I}_{45}^c(2x, 2y + 1) \leftarrow \bar{I}^c(2x, 2y + 1)$
- 14:        $\bar{I}_0^c(2x + 1, 2y + 1) \leftarrow \bar{I}^c(2x + 1, 2y + 1)$
- 15:        $\bar{I}_{135}^c(2x + 1, 2y) \leftarrow \bar{I}^c(2x + 1, 2y)$
- 16:   **for** every  $\{0, 45, 90, 135\}$  **in**  $a$  **do** ▷ Polar. channels est.
- 17:     **for** every {Red, Green, Blue} **in**  $c$  **do**
- 18:        $\hat{I}_a^c(2x, 2y) \leftarrow F_{PPI}(s, t) * \bar{I}_a^c(2x, 2y)$  ▷ Convolution
- 19: **return**  $\hat{I}_a^c(2x, 2y)$  ▷ Output is a 12 channels polar. im.

which is summed up in Fig. 9. It is, however, noted that using full-resolution images in further calculations requires more computational power.

The first step consists of performing upsampling, in a way that the four different polarizer angle images are combined again in one image. This process is repeated for the three different color channels. Then, the three color channel images are subsampled, as in Fig. 3. In the final step, the

12 channels are convolved with the PPI kernel (13), to estimate the missing information in each channel. The resulting image is a 12-channel image, in which every channel exhibits the full resolution provided by the polarization CIS.

## V. COLOR POLARIZATION IMAGE OPTIMIZATION

In this section, we propose two methods for optimizing images of a polarization CIS, using either irradiance, or polarization. The output of the presented methods will be further processed, using one of the laser line extraction methods presented in Section VI.

New abbreviations for the optimization methods are introduced, as follows: standard grayscale optimization (SGO), minimum linearly polarized irradiance optimization (MLPIO), and polarization intensity optimization (PIO).

### A. Optimization Based on Minimum Linearly Polarized Irradiance

This method for optimizing the 12-channel image produced in Section IV is based on irradiance processing. The method is depicted in Fig. 10, and it assumes a 12-channel image as its input. In the first step, the 12 channels are reduced to four channels by computing a monochrome version of the image, which contains the information of the four linear polarization angles. Then, the four channels are analyzed in a pixel-by-pixel manner, and only the minimum irradiance value  $\hat{m}_p$  of each pixel position in every channel is kept. Mathematically, this is described as

$$\hat{m}_p(x, y) = \min[I_a^{\text{gray}}(x, y)], \quad a \in \{0, 45, 90, 135\}. \quad (19)$$

As a result, a single-channel optimized image that represents the minimum linearly polarized irradiance is produced. The method is compactly presented in Algorithm 3.

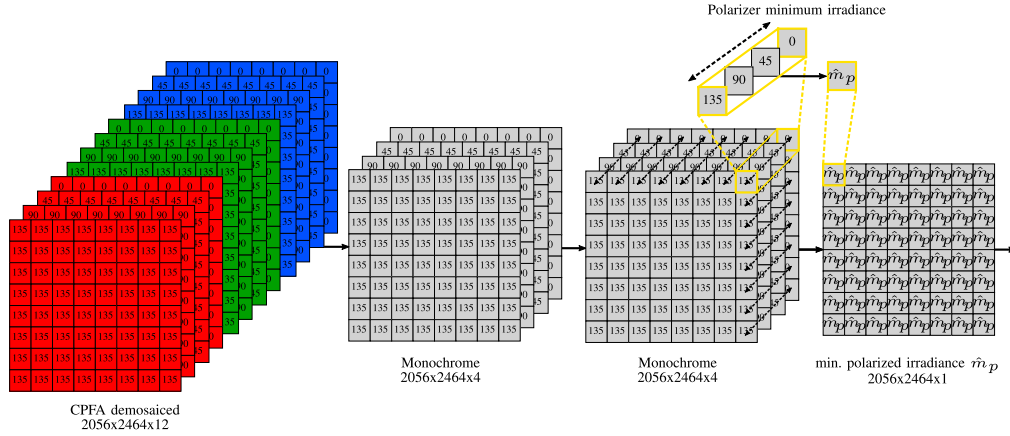


Fig. 10. Polarization image optimization based on the minimum linearly polarized irradiance. Full-resolution images are shown, but the procedure is the same for one-quarter resolution images.

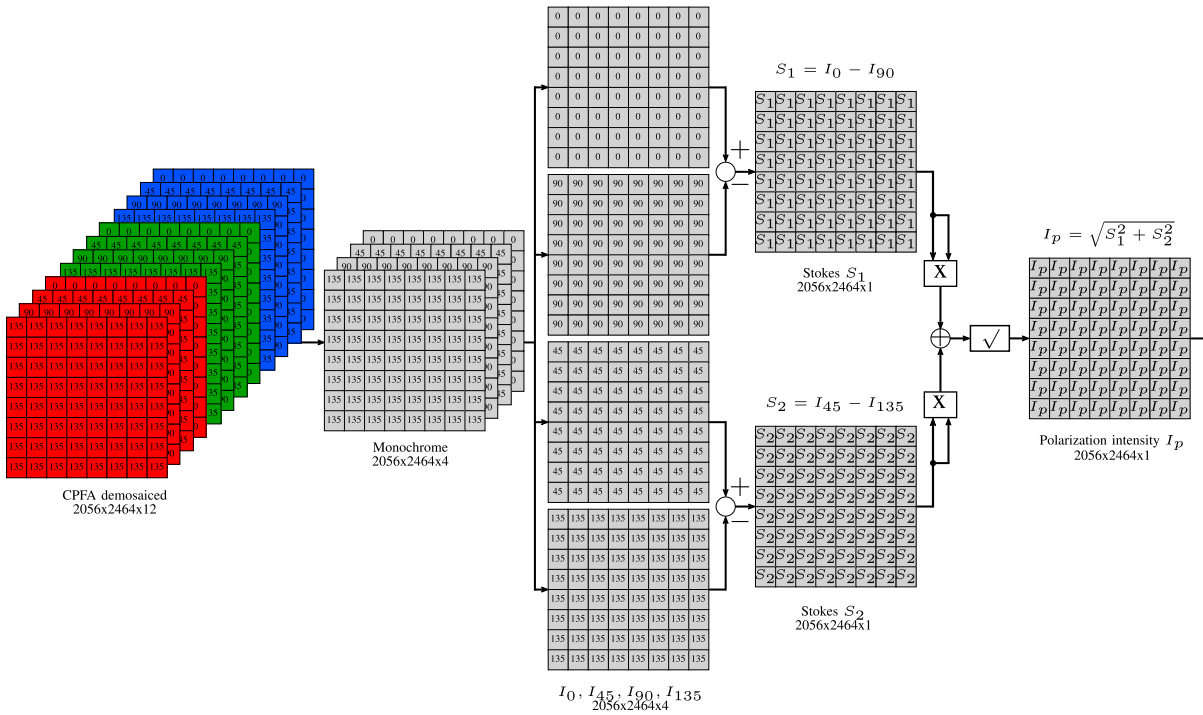


Fig. 11. Polarized image optimization based on the polarization intensity. Full-resolution images are shown, but the procedure is the same for one-quarter resolution images.

### B. Optimization Based on Polarization Intensity

In this method, the optimized image is produced based on polarization processing. The initial part of the method is similar to Section V-A, as we assume a 12-channel image as its input. Then, the 12 channels are reduced to four channels, by computing a monochrome version of the image, which contains the information of the four linear polarization angles. The rest of the method is depicted in Fig. 11. As it was described in Section II-B, the state of polarization of the light can be represented using the Stokes parameters (4). The total linear polarization intensity  $I_{Lpol}$  can be computed using the Stokes parameters as

$$I_{Lpol} = \sqrt{S_1^2 + S_2^2} \quad (20)$$

where the circular component  $S_3$  is removed. Then, (20) can be expanded using (4) as

$$I_{Lpol} = \sqrt{[(I_0 - I_{90})]^2 + [(I_{45} - I_{135})]^2}. \quad (21)$$

Following this procedure, an optimized single-channel image is obtained by means of polarization processing. The method is compactly presented in Algorithm 4.

## VI. POLARIZATION IMAGES LASER LINE EXTRACTION

In this section, two novel methods for extracting the laser line from the optimized polarization images are presented. Both methods are based on the output of the optimization stage explained in Section V.



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**Algorithm 3** Minimum Linearly Polarized Irradiance Image Creation (MinLPI)
 

---

**Input:** 12 channels polarization image  $I_a^c(x, y)$ ,  
 $a \in \{0, 45, 90, 135\}$ ,  $c \in \{\text{Red, Green, Blue}\}$   
**Output:** Minimum linearly polarized irradiance image  $\hat{m}_p(x, y)$

- 1: **procedure** MINLPI( $I_a^c(x, y)$ )
- 2: **for** every  $\{0, 45, 90, 135\}$  **in**  $a$  **do**  $\triangleright$  from 12 to 4 channels
- 3: **for** every pixel **in**  $x$  row **do**
- 4: **for** every pixel **in**  $y$  column **do**
- 5:  $I_a^{\text{gray}}(x, y) \leftarrow 0.3I_a^R(x, y) + 0.59I_a^G(x, y) + 0.11I_a^B(x, y)$   $\triangleright$  Monochrome
- 6: **for** every  $\{0, 45, 90, 135\}$  **in**  $a$  **do**  $\triangleright$  from 4 to 1 channel
- 7: **for** every pixel **in**  $x$  row **do**
- 8: **for** every pixel **in**  $y$  column **do**
- 9:  $\hat{m}_p(x, y) \leftarrow \min[I_a^{\text{gray}}(x, y)]$   $\triangleright$  Minimum
- 10: **return**  $\hat{m}_p(x, y)$   $\triangleright$  Output is a 1 channel image

---



---

**Algorithm 4** Polarization Intensity Image Creation (PolarInt)
 

---

**Input:** 12 channels polarization image  $I_a^c(x, y)$ ,  
 $a \in \{0, 45, 90, 135\}$ ,  $c \in \{\text{Red, Green, Blue}\}$   
**Output:** Polarization Intensity image  $I_p(x, y)$

- 1: **procedure** POLARINT( $I_a^c(x, y)$ )
- 2: **for** every  $\{0, 45, 90, 135\}$  **in**  $a$  **do**  $\triangleright$  from 12 to 4 channels
- 3: **for** every pixel **in**  $x$  row **do**
- 4: **for** every pixel **in**  $y$  column **do**
- 5:  $I_a^{\text{gray}}(x, y) \leftarrow 0.3I_a^R(x, y) + 0.59I_a^G(x, y) + 0.11I_a^B(x, y)$   $\triangleright$  Monochrome
- 6: **for** every pixel **in**  $x$  row **do**
- 7: **for** every pixel **in**  $y$  column **do**
- 8:  $S_1(x, y) \leftarrow I_0^{\text{gray}}(x, y) - I_{90}^{\text{gray}}(x, y)$   $\triangleright$  Stokes  $S_1$
- 9:  $S_2(x, y) \leftarrow I_{45}^{\text{gray}}(x, y) - I_{135}^{\text{gray}}(x, y)$   $\triangleright$  Stokes  $S_2$
- 10:  $I_p(x, y) \leftarrow \sqrt{S_1(x, y)^2 + S_2(x, y)^2}$   $\triangleright$  Polar. Int.
- 11: **return**  $I_p(x, y)$   $\triangleright$  Output is a 1 channel image

---

### A. Polarized FIR-COG Method

In this method, the strategy for computing the coordinates of the laser line in the optimized polarization image is based on the COG explained in Section II-D.3, which is adapted for the polarization vision system. The algorithm, shown in Algorithm 5, is developed for the raw image data coming from the polarization CIS. The raw image is demosaiced using one-quarter resolution and converted to its full resolution (see Section IV). Then, the demosaiced image undergoes one of the two optimization methods presented in Section V. The resulting image of the chosen optimization method is thresholded, using a constant value via a comparator operation. This thresholded image is convolved on a column-by-column basis with a 1-D S-G FIR filter kernel for smoothing (see Section II-D.2). Then, every column is analyzed pixel-by-pixel, to detect where the left edge of the laser profile starts. Once the left edge of the laser is found, the part of the column containing the laser signal is processed using the COG algorithm. As a result, the  $x$  coordinates of the laser line in the image with subpixel precision can be found as

$$X_C = X_L + \frac{M_\Sigma}{I_\Sigma} \quad (22)$$

---

**Algorithm 5** Polarized FIR-COG Method (PolarFIRCOG)
 

---

**Input:** Polarized image sensor raw image  $I_{\text{raw}}(x, y)$   
**Output:** Position of the laser line in image coordinates  $X_C(1, y)$

- 1: **procedure** POLARFIRCOG( $I_{\text{raw}}(x, y)$ )
- 2:  $\tilde{I}_a^c(\frac{x}{2}, \frac{y}{2}) \leftarrow \text{PolarDemQR}(I_{\text{raw}}(x, y))$   $\triangleright$  Demos. (1/4) res.
- 3: **if** Full Resolution demosaicing **then**
- 4:  $\hat{I}_a^c(x, y) \leftarrow \text{PolarDemFR}(\tilde{I}_a^c(\frac{x}{2}, \frac{y}{2}))$   $\triangleright$  Demos. Full res.
- 5: **if** Minimum linearly polarized irradiance method **then**
- 6:  $I_{\text{opt}}(x, y) \leftarrow \text{MinLPI}(\hat{I}_a^c(x, y))$
- 7: **else if** Polarization Intensity method **then**
- 8:  $I_{\text{opt}}(x, y) \leftarrow \text{PolarInt}(\hat{I}_a^c(x, y))$
- 9: **for** every pixel **in**  $x$  row **do**
- 10: **for** every pixel **in**  $y$  column **do**
- 11: **if**  $I_{\text{opt}}(x, y) > \text{Threshold}$  **then**
- 12:  $I_T(x, y) \leftarrow I_{\text{opt}}(x, y)$   $\triangleright$  Thresholded image
- 13: **for** every  $j$  column **in**  $I_T(x, y_j)$  **do**
- 14:  $I_s(x, 1) \leftarrow F_s(k, 1) * I_T(x, y_j)$   $\triangleright$  S-G smoothing filter
- 15:  $X_L \leftarrow 0$   $\triangleright$  Initialize left edge of laser profile
- 16: **for** every  $i$  pixel **in**  $I_s(x_i, 1)$  **do**
- 17: **if**  $X_L = 0$  **and**  $I_s(x_i, 1) > 0$  **then**
- 18:  $X_L \leftarrow x_i$   $\triangleright$  Left edge of laser profile
- 19:  $I_\Sigma \leftarrow \sum I_s(x_i)$   $\triangleright$  Sum of intensities
- 20:  $M_\Sigma \leftarrow \sum x_i I_s(x_i)$   $\triangleright$  Sum of moments
- 21:  $X_C(1, y_j) \leftarrow X_L + \frac{M_\Sigma}{I_\Sigma}$   $\triangleright$  COG position of the col.
- 22: **return**  $X_C(1, y)$   $\triangleright$  Laser coords. with sub-pixel precision

---

where  $X_L$  is the  $x$  coordinate of the left edge pixel, the sum of moments  $M_\Sigma = \sum x_i I(x_i, y_j)$ , and the sum of intensities  $I_\Sigma = \sum I(x_i, y_j)$ . The full process of the polarized FIR-COG method is depicted in the upper part of Fig. 12.

### B. Polarized FIR-Peak Method

In this method, the strategy for computing the coordinates of the laser line in the optimized polarization image is based on the FIR-Peak zero-crossing explained in Section II-D.4, which is adapted for the polarization vision system. As previously mentioned, the algorithm, shown in Algorithm 6, is developed for the raw image data coming from the polarization CIS. The preprocessing, optimization, thresholding, and smoothing steps are the same as explained in Section VI-A. The smoothed image is then convolved on a column-by-column basis with a 1-D S-G FIR filter kernel for computing the first derivative (see Section II-D.2). Then, every column is analyzed in a pixel-by-pixel manner, to detect the zero-crossing of the differentiated column. Once the zero-crossing is found, the estimated zero-crossing position is computed. As a result, the  $x$  coordinates of the laser line in the image, with subpixel precision, can be found as

$$\hat{X} = x_i - \frac{I_d(x_i) \cdot (x_{i+1} - x_i)}{I_d(x_{i+1}) - I_d(x_i)}. \quad (23)$$

The full process of the polarized FIR-Peak method is depicted in the lower part of Fig. 12.

## VII. EXPERIMENTAL STUDY

In this section, an experimental study on the performance of the proposed methods is evaluated. This is done by comparing

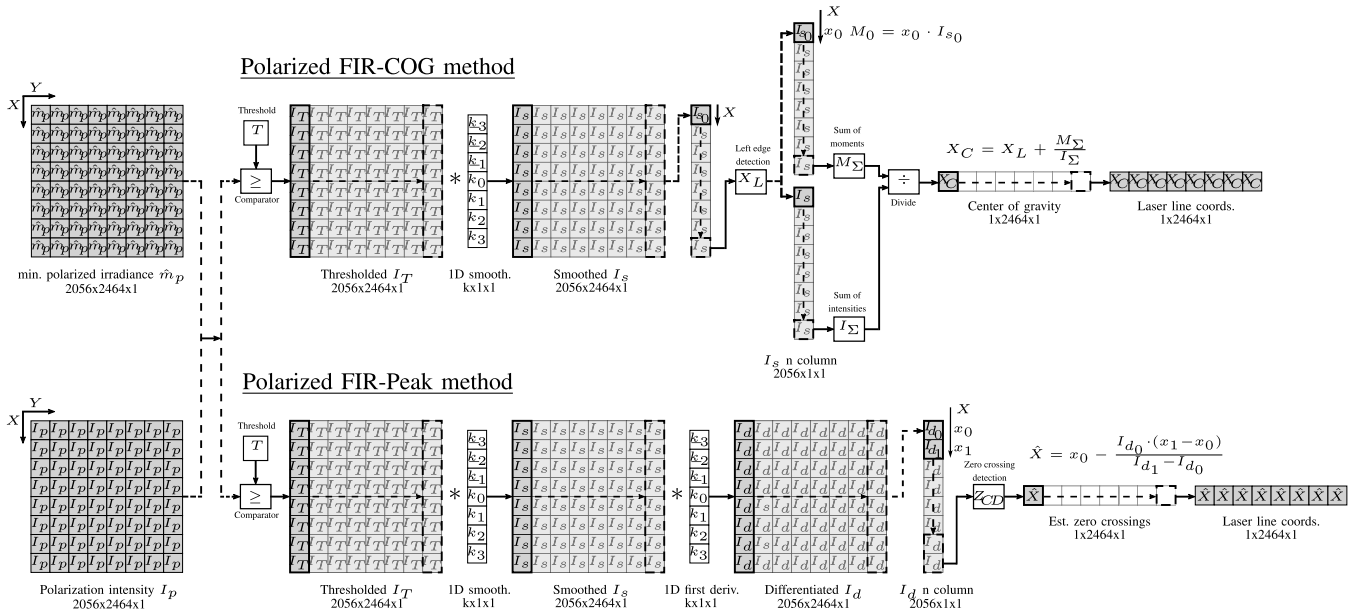


Fig. 12. Polarized FIR-COG and polarized FIR-Peak methods for laser line extraction from the optimized polarization images.

#### Algorithm 6 Polarized FIR-Peak Method (PolarFIRPeak)

**Input:** Polarized image sensor raw image  $I_{raw}(x, y)$   
**Output:** Position of the laser line in image coordinates  $\hat{X}(1, y)$

- 1: **procedure** POLARFIRPEAK( $I_{raw}(x, y)$ )
- 2:  $\tilde{I}_a^c(\frac{x}{2}, \frac{y}{2}) \leftarrow \text{PolarDemQR}(I_{raw}(x, y))$   $\triangleright$  Demos. (1/4) res.
- 3: **if** Full Resolution demosaicing **then**
- 4:  $\hat{I}_a^c(x, y) \leftarrow \text{PolarDemFR}(\tilde{I}_a^c(\frac{x}{2}, \frac{y}{2}))$   $\triangleright$  Demos. Full res.
- 5: **if** Minimum linearly polarized irradiance method **then**
- 6:  $I_{opt}(x, y) \leftarrow \text{MinLPI}(\hat{I}_a^c(x, y))$
- 7: **else if** Polarization Intensity method **then**
- 8:  $I_{opt}(x, y) \leftarrow \text{PolarInt}(\hat{I}_a^c(x, y))$
- 9: **for every pixel in**  $x$  row **do**
- 10: **for every pixel in**  $y$  column **do**
- 11: **if**  $I_{opt}(x, y) > \text{Threshold}$  **then**
- 12:  $I_T(x, y) \leftarrow I_{opt}(x, y)$   $\triangleright$  Thresholded image
- 13: **for every**  $j$  column **in**  $I_T(x, y_j)$  **do**
- 14:  $I_s(x, 1) \leftarrow F_s(k, 1) * I_T(x, y_j)$   $\triangleright$  S-G smoothing filter
- 15:  $I_d(x, 1) \leftarrow F_d(k, 1) * I_s(x, 1)$   $\triangleright$  S-G first deriv. filter
- 16: **for every**  $i$  pixel **in**  $I_d(x_i)$  **do**
- 17:  $\bar{X} \leftarrow x_i - \frac{I_d(x_i) \cdot (x_{i+1} - x_i)}{I_d(x_{i+1}) - I_d(x_i)}$   $\triangleright$  Zero crossing pred.
- 18: **if**  $\bar{X} > 0$  **then**
- 19:  $\hat{X}(1, y_j) \leftarrow \bar{X}$   $\triangleright$  Zero crossing est.
- 20: **return**  $\hat{X}(1, y)$   $\triangleright$  Laser coords. with sub-pixel precision

the results of the proposed polarized methods, with the results of a standard (i.e., nonpolarized) CIS camera. The polarization vision system in this experimental study was implemented using the hardware and software architecture presented in [8].

#### A. Setup

The experiments in this study were conducted using the test setup shown in Fig. 13. The setup consists of a semicircular rack (1), with a track for a sensor trolley (2). The trolley could be placed tangentially to (1), at the given angles toward the horizontal plane. The trolley offered a stepless angle

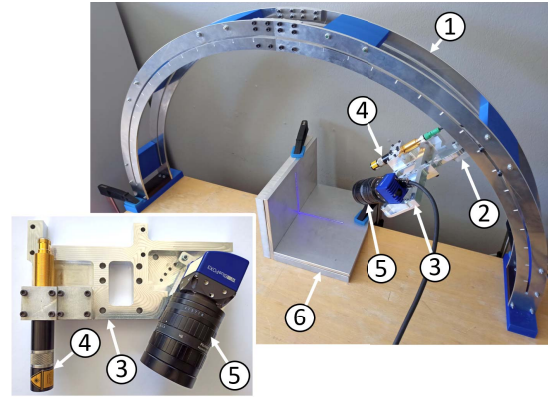


Fig. 13. Test setup: (1) rack, (2) sensor trolley, (3) sensor bracket, (4) blue laser projector, (5) polarization CIS camera, and (6) aluminum plates.

adjustment range of  $10^\circ$ – $90^\circ$ . A sensor bracket (3) was hinged to the sensor trolley, such that an out-of-rack-plane bracket tilt angle could be adjusted. This sensor bracket offered an angle adjustment range of  $0^\circ$ – $\pm 50^\circ$ , with a  $10^\circ$  step angle. A blue laser line projector (4) and a polarization CIS camera (5) were fixed to the bracket (3). The camera angle measured from the laser axis was  $28^\circ$ . Two aluminum plates (6), attached to form a right-angle corner, were located approximately in the geometrical rack center. The trolley, camera, and lateral tilt angles are graphically shown in Fig. 14.

The first camera model used in the tests was a MATRIX VISION mvBlueFOX3-2051pC, which integrates the Sony IMX250MYR 5.07 Megapixels global shutter and color-capable polarization CIS. The C-Mount FUJINON 1:1.4/16 mm CF16 lens was mounted on the camera, where the maximum aperture  $f/1.4$  was used in all tests. The laser was a Z-LASER Z20M18H3-F-450-LP45, outputting 20 mW of power at 450 nm and projecting a line with a homogeneous distribution of intensity.

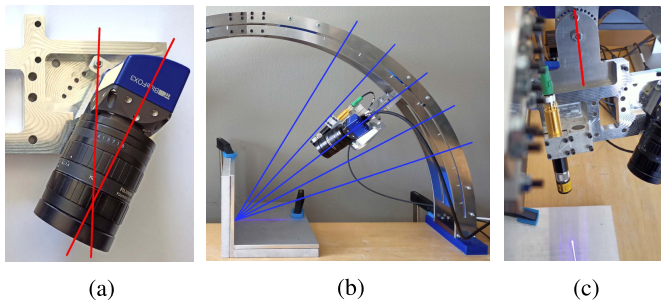


Fig. 14. (a) Polarization CIS camera angle, (b) trolley angle, and (c) lateral tilt angle.

For the comparison study, a second and nonpolarized CIS was needed. An OMRON STC—MCS500U3V that integrated a Sony IMX264LLR 5.0 Megapixels global shutter and color-capable CIS was chosen. The same above-mentioned lens and aperture were used for the OMRON camera tests.

The shutter speed was set manually to 1/30 s, for both cameras. This exposure time configuration was used in all experiments.

The test plates were made of aluminum alloy 6082, which is one of the most common alloys used in industrial aluminum welding [53]. The distance from the laser projector to the AA6082 plates was approximately 300 mm.

The proposed methods were implemented in a C++ application, running on a real-time kernel within the Linux4Tegra operating system (OS). This OS was running on an Nvidia Jetson AGX Xavier kit. For more details on the hardware and communication setup, the reader is referred to [8].

### B. Methodology and Test Program

The performance of the proposed methods was studied for two different CIS technologies, different sensor bracket orientations, and under different illumination conditions. Three different trolley angles were considered: 25°, 35°, and 45°. For each trolley angle, two different lateral tilt angles were considered: 0° and 10°. A small tilt angle was selected as it is feasible in practical applications when it is desired to scan as close as possible to a 0° tilt angle. This way the scanned geometry is represented correctly, while large tilt angles rather “stretch” the nominal geometry in the scan data. Furthermore, the lateral tilt angle of 10° was chosen because the tilted laser projector causes interreflections to appear on the aluminum plates. These interreflections produce noise (unwanted variations) in the laser images (see Fig. 15). In addition, two different illumination conditions were used for each orientation: a standard ambient light with a measured illuminance value of approximately 400 lux, and a strong ambient light with a measured illuminance value of approximately 1300 lux. Then, and for each of the mentioned conditions, the following data processing steps were done.

- 1) The raw image in Fig. 16(a) is captured.
- 2) The different color polarization angle  $I_0$ ,  $I_{45}$ ,  $I_{90}$ , and  $I_{135}$  images in Fig. 16(b)–(e) were preprocessed by means of the full-resolution CPFA demosaicing method explained in Section IV.
- 3) The MLPIO image  $\hat{m}_p$  in Fig. 16(l) was computed by means of the method explained in Section V-A.

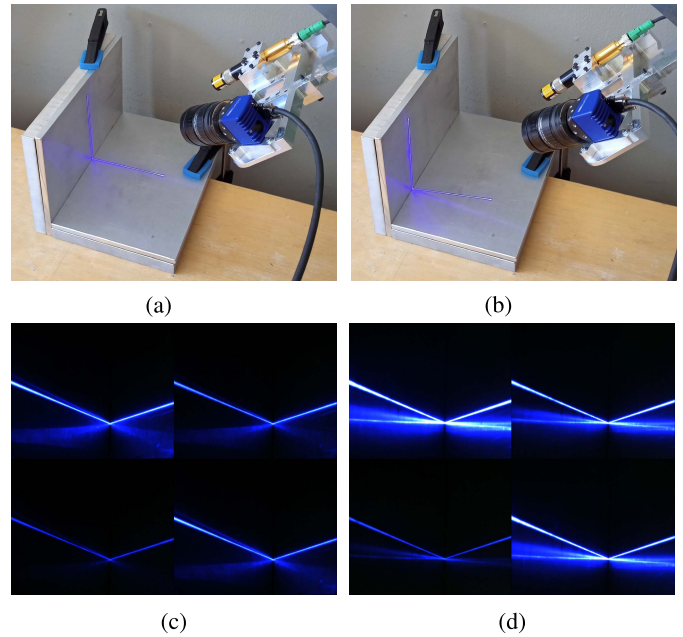


Fig. 15. Acquisition and resulting polarization image. A lateral tilt leads to a skewed laser projection, increasing the noise. (a) Acquisition, 0° lateral tilt. (b) Acquisition, 10° lateral tilt. (c) Polarization image, 0° lateral tilt. (d) Polarization image, 10° lateral tilt.

- 4) The Stokes parameter  $S_0$ ,  $S_1$ , and  $S_2$  images in Figures 16(f)–(h) were computed by means of the equations in 4.
- 5) The PIO image  $I_p$  in Fig. 16(k) was computed by means of the method explained in Section V-B.
- 6) The polarized FIR-COG images of MLPIO in Fig. 16(o) and PIO in Fig. 16(m) were computed by means of the method explained in Section VI-A.
- 7) The polarized FIR-Peak images of MLPIO in Fig. 16(p) and PIO in Fig. 16(n) were computed by means of the method explained in Section VI-B.

For the test runs where the standard (nonpolarized) camera was used, the data processing was done as close as possible to the previously mentioned steps. The following was altered as follows.

- 1) The standard CFA demosaicing explained in Section II-C.3 was performed in the preprocessing part, since a standard CIS does not implement a PFA.
- 2) The RGB images were converted to a grayscale equivalent, as explained in Section II-D.1, in the optimization part. Since the image does not contain any polarization information.

More intermediate processing results are presented in Fig. 16, providing the reader with a comprehensive view of the data processing steps.

Regarding the laser line extraction methods shown in Fig. 12, the global threshold was adjusted manually during the execution of the program to a suitable value and applied to the whole image. Meanwhile, the S-G FIR filter kernels for smoothing and first derivative, as explained in Section II-D.2, used for all the experiments, are shown in Table I. These kernels were chosen empirically from [49], for the specific lens, and laser thickness used in our setup.

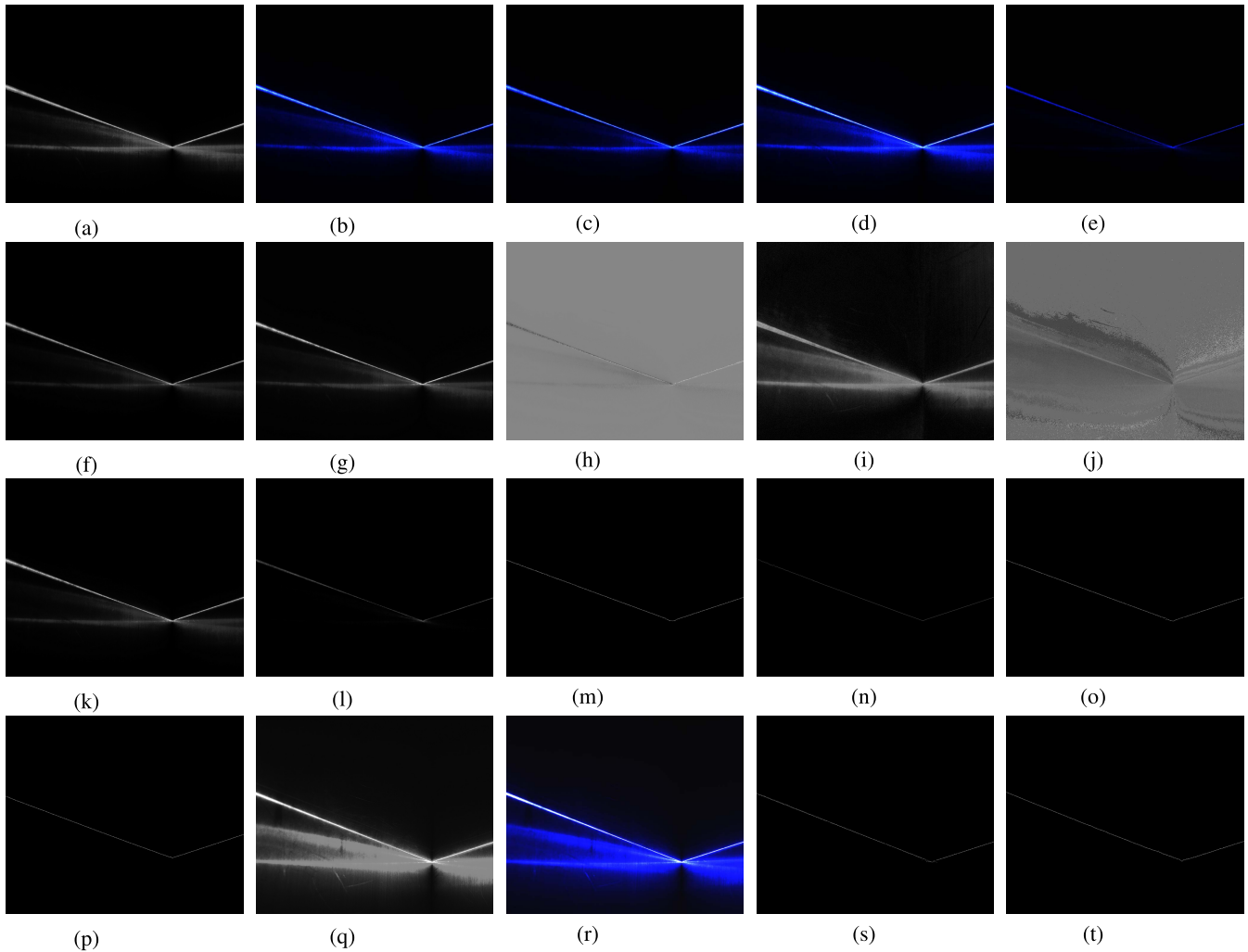


Fig. 16. Visualization of the image results from different data processing steps. (a) Polarization raw. (b)  $I_0$ . (c)  $I_{45}$ . (d)  $I_{90}$ . (e)  $I_{135}$ . (f)  $S_0$ . (g)  $S_1$ . (h)  $S_2$ . (i) DoLP. (j) AoP. (k) PIO,  $I_p$ . (l) MLPIO,  $\hat{m}_p$ . (m) PIO FIR-COG. (n) PIO FIR-Peak. (o) MLPIO FIR-COG. (p) MLPIO FIR-Peak. (q) Standard raw. (r) Standard color. (s) SGO FIR-COG. (t) SGO FIR-Peak.

Once all the data needed were acquired, a method and program for postprocessing the data acquired by both, the polarization, and standard cameras had to be devised in such a way that the results of both CIS could be compared.

The synthetic (i.e., ground truth) laser line coordinates were computed by carefully choosing three points in every image manually and doing piecewise linear interpolation between the points afterward. Due to the arrangement of the test plates in Fig. 13, the shape of the laser in the image was known to have a V-shape. Then, the three points were selected at the beginning, corner, and ending of the laser line.

Both CISs have a resolution of approximately 5 MP. The polarization CIS of the MATRIX VISION camera has an image size of  $[2056 \times 2464]$  pixels, whereas the CIS of the Omron camera has an image size of  $[2048 \times 2448]$  pixels. In order to do a pixel-wise comparison between the CIS, eight rows, and 16 columns were cropped from the polarization CIS images.

### C. Results

The performance of the methods was evaluated and compared in terms of the mean absolute error (MAE) in pixels, and

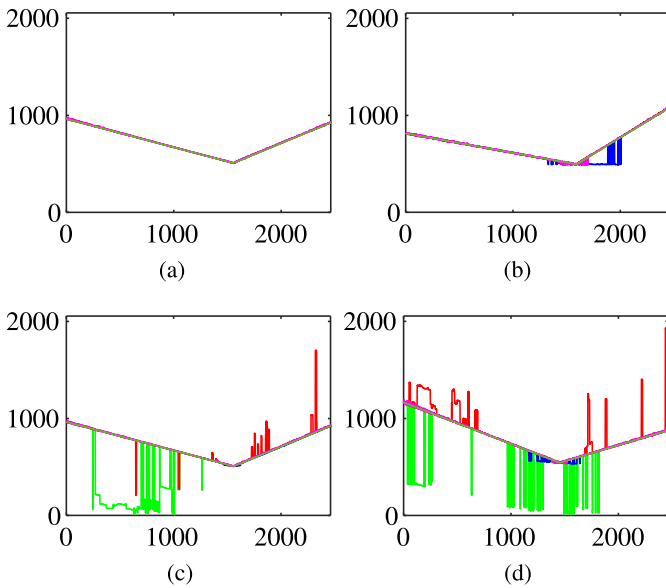
TABLE I  
S-G FIR FILTER KERNELS (1-D, 7 POINTS AND CUBIC) USED FOR THE LASER LINE EXTRACTION

Point k	-3	-2	-1	0	1	2	3	norm
Smoothing	-2	3	6	7	6	3	-2	21
1st deriv.	22	-67	-58	0	58	67	-22	252

the peak signal-to-noise ratio (PSNR) in dB, both relative to the synthetic laser. Since these error metrics are widely used in the literature, the reader is referred to [54] for the MAE and to [55] for the PSNR calculation formulas. To improve the reliability of the results, the processing steps given in Section VII-B were repeated for ten different sets of images. The averaged MAE and PSNR results over ten sets of images for all test cases are conveniently collected in Tables II and III.

For the standard ambient light test cases, the results from Table II can be summed up as follows.

On the one hand, for the  $0^\circ$  tilt angle over all the trolley angles, the error and PSNR for the polarization CIS were in the range of 0.54–3.58 pixels and 48.66–36.85 dB. Whereas, for the standard CIS the error and PSNR were in the range



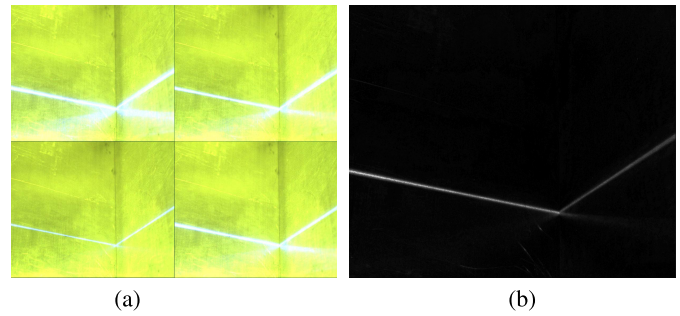
**Fig. 17.** Laser line coordinates with different noise sources (vertical axis inverted for displaying purposes). Color code for the Synthetic laser (green) and the proposed methods: MLPIO FIR-COG (light green), MLPIO FIR-Peak (red), PIO FIR-COG (blue), PIO FIR-Peak (pink). (a) Standard ambient light,  $0^\circ$  lateral tilt. (b) Standard ambient light,  $10^\circ$  lateral tilt. (c) Strong ambient light,  $0^\circ$  lateral tilt. (d) Strong ambient light,  $10^\circ$  lateral tilt.

of 1.20–4.48 pixels and 43.90–35.12 dB. It is noted that the polarization CIS performed marginally better for all trolley angle test cases. The minimum error and maximum PSNR were achieved using the FIR-COG laser extraction method for all trolley angles tested. For the polarization CIS, the MLPIO performed better than the PIO for all trolley angles tested. The MAE and PSNR results suggested that both, standard and polarization CISs, perform well under given conditions.

On the other hand, for the  $10^\circ$  tilt angle over all the trolley angles, the results were quite different. The error and PSNR for the polarization CIS were in the range of 1.22–12.55 pixels and 43.49–17.04 dB. Whereas for the standard CIS, the error and PSNR were in the range of 1.85–7.42 pixels and 36.94–22.20 dB. In these test cases, where the  $10^\circ$  tilt angle was present, the polarization CIS performed better than the standard CIS for all trolley angles tested. For the polarization CIS, the MLPIO combined with the FIR-Peak performed better than all other optimization and laser extraction methods. The results showed a clear advantage of using the polarization CIS under given conditions.

For the strong ambient light test cases, the results from Table III can be summed up as follows.

On the one hand, for the  $0^\circ$  tilt angle over all the trolley angles, the error and PSNR for the polarization CIS were in the range of 1.36–6.38 pixels and 39.80–14.37 dB using the PIO. Meanwhile, using the MLPIO, were in the range of 65.23–149.90 pixels and 3.45–(–1.8) dB. For the standard CIS, the error and PSNR were in the range of 52.96–566.84 pixels and 3.44–(–9.6) dB. Besides, the minimum error and maximum PSNR for the polarization CIS were achieved using the FIR-COG laser extraction method. These MAE and PSNR results also showed a clear advantage of using the polarization CIS under given conditions.



**Fig. 18.** Polarization image with strong ambient light example. (a) Before optimization. (b) PIO,  $I_p$  optimized image.

On the other hand, for the  $10^\circ$  tilt angle over all the trolley angles, the error and PSNR for the polarization CIS were in the range of 3.51–18.87 pixels and 28.24–12.36 dB using the PIO. Meanwhile, using the MLPIO were in the range of 45.68–187.46 pixels and 5.09–(–3.1) dB. For the standard CIS, the error and PSNR were in the range of 149.48–303.51 pixels and (–1.2)–(–5.7) dB. In contradiction with the results for the  $0^\circ$  tilt angle, this time the FIR-Peak laser extraction method performed better than the FIR-COG method. The MAE and PSNR results once again showed a clear advantage of using the polarization CIS under given conditions.

Different areas of the laser line image could be affected by the noise present in the measurements, depending on the noise source. Either a big area of the image because of the strong ambient light, or a more localized area of the image in the vicinity of the laser line, because of the interreflections caused by the lateral tilt. An example of incorrect estimation of the laser line coordinates (i.e., large MAE), due to the mentioned noise affecting the laser line extraction, is given in Fig. 17.

#### D. Discussion

This section contains the discussion of the results given in Section VII-C and the outcome of our experimental study.

Performance of all methods for the test cases under standard ambient light with  $0^\circ$  lateral tilt is considered acceptable. Whereas the MLPIO FIR-COG and SGO FIR-COG methods only marginally outperform all the others. It was expected that all methods (even with the standard CIS) would perform well in these test cases [see Fig. 17(a)]. The absence of a lateral tilt reduces the noise in the area of the image in the vicinity of the laser line, and the standard ambient light facilitates achieving a high PSNR laser image. The higher accuracy of the MLPIO method can be attributed to its better ability to filter the diffuse reflections [see Fig. 16(l)], which can be considered the dominant noise source for the test cases under standard ambient light with no lateral tilt. It is notable that, for the  $10^\circ$  tilt test cases, MLPIO is still the preferred optimization method for the polarization CIS, but in combination with FIR-Peak laser line extraction. Regarding the  $10^\circ$  tilt test cases [see Fig. 17(b)], and in addition to the mentioned diffuse reflections, interreflections are caused by the lateral tilt, affecting the area of the image in the

TABLE II

MAE IN PIXELS (PSNR IN dB INSIDE PARENTHESES) WITH STANDARD AMBIENT LIGHT. THE BEST RESULT IS HIGHLIGHTED IN RED

Sensor	Methods		0 deg lateral tilt			10 deg lateral tilt		
	Optimization	Laser Ext.	25	35	45	25	35	45
	Std. CIS	Std. grayscale (SGO)	FIR-COG FIR-Peak	1.20 (43.90) 2.56 (37.83)	1.50 (40.96) 4.48 (35.12)	1.34 (42.83) 4.24 (36.14)	7.42 (22.20) 4.00 (27.56)	6.57 (22.77) 3.03 (31.30)
Polar. CIS	Min. linearly polar. irradiance (MLPIO)	FIR-COG FIR-Peak	<b>0.86 (47.37)</b> 1.78 (42.25)	<b>0.74 (48.06)</b> 1.22 (44.60)	<b>0.54 (48.66)</b> 1.26 (42.42)	<b>1.27 (42.39)</b> <b>1.22 (43.49)</b>	<b>1.22 (43.49)</b> 2.08 (32.86)	<b>1.25 (43.36)</b> 1.84 (38.66)
	Polarization intensity (PIO)	FIR-COG FIR-Peak	1.54 (44.82) 2.96 (39.07)	1.65 (43.88) 2.86 (39.66)	1.85 (39.80) 3.58 (36.85)	12.55 (17.04) 3.59 (26.87)	8.05 (19.22) 3.14 (35.90)	6.91 (20.41) 2.89 (35.72)

TABLE III

MAE IN PIXELS (PSNR IN dB INSIDE PARENTHESES) WITH STRONG AMBIENT LIGHT. THE BEST RESULT IS HIGHLIGHTED IN RED

Sensor	Methods		0 deg lateral tilt			10 deg lateral tilt		
	Optimization	Laser Ext.	25	35	45	25	35	45
	Std. CIS	Std. grayscale (SGO)	FIR-COG FIR-Peak	123.61 (-0.1) 52.96 (3.44)	566.84 (-9.6) 374.86 (-6.8)	438.95 (-7.1) 299.58 (-4.5)	241.7 (-4.2) 170.84 (-2.2)	303.51 (-5.7) 149.48 (-1.6)
Polar. CIS	Min. linearly polar. irradiance (MLPIO)	FIR-COG FIR-Peak	149.90 (-1.8) 125.32 (0.36)	82.27 (2.04) 75.70 (1.62)	67.19 (3.45) 65.23 (2.86)	179.16 (-2.7) 135.78 (0.10)	187.46 (-3.1) 163.91 (-1.3)	54.02 (5.09) 45.68 (4.01)
	Polarization intensity (PIO)	FIR-COG FIR-Peak	<b>1.36 (39.80)</b> 3.01 (32.17)	<b>1.72 (23.7)</b> 6.28 (14.40)	<b>2.35 (25.34)</b> 6.38 (14.37)	<b>3.51 (28.24)</b> <b>6.17 (16.36)</b>	<b>6.17 (16.36)</b> 18.87 (12.36)	<b>6.93 (14.35)</b> 17.75 (14.14)

vicinity of the laser line (see Fig. 15). These interreflections create their own diffuse reflections, which can be filtered by means of using the MLPIO [see Fig. 15(d)], which is why it performs better than the standard and PIO methods. Although the MLPIO cannot filter the noise produced by the interreflection itself, the FIR-Peak method manages to filter this noise more efficiently than FIR-COG and that is why the MLPIO in combination with FIR-Peak outperforms the other methods in the 10° tilt test cases.

Regarding the test cases under strong ambient light conditions, the PIO method provided far better performance, when compared to the SGO and MLPIO methods. In these test cases, the irradiance value of the laser is comparable to the noise caused by the strong ambient light. Hence, the SGO and MLPIO methods achieve a low PSNR laser image. Providing an unacceptable performance, as they are based on irradiance, and the strong ambient light becomes an interfering input. The MAE difference is large, resulting in that only the PIO method can be recommended under strong ambient light conditions, where unpredictable reflections appear across the surface of the aluminum plates [see Fig. 18(a)]. The better performance can be attributed to the ability of the PIO method to efficiently filter the nonpolarized ambient light noise, which can be considered the dominant noise source under the strong ambient light conditions (see Fig. 18). As in the previous 10° tilt test cases, the FIR-Peak method manages to filter the interreflections noise more efficiently than FIR-COG.

An interesting result is that the PIO method performs almost identically for both, standard, and ambient light conditions. This robust filtering of the nonpolarized light is not only practical under strong ambient light scenarios, but also in cases where the PSNR of the laser image captured by the CIS is low, because of one or a combination of the following circumstances: strong ambient light, too long exposure time, incorrect or lack of aperture control, or the laser power outputted by the projector is too low. This filtering is done by exploiting the polarization capabilities of the color polarization

TABLE IV

PREFERRED METHODS UNDER GIVEN CONDITIONS

Ambient Light	0 deg lateral tilt (No interreflections noise)	10 deg lateral tilt (Interreflections noise)
Standard (High PSNR)	MLPIO FIR-COG	MLPIO FIR-Peak
Strong (Low PSNR)	PIO FIR-COG	PIO FIR-Peak

CIS, without any optical narrow bandpass filters, hence leaving the color capabilities of the CIS available.

The PIO method proved to be robust under all test conditions, delivering acceptable results. Besides, the MLPIO method is more accurate because of its ability to filter the diffuse component of the reflections and interreflections, when the PSNR of the laser image captured by the CIS is high but delivers unacceptable results when it is low. Meanwhile, the reason behind the slightly worse accuracy of the PIO method, when compared with the MLPIO method, is that it cannot filter the diffuse reflections as effectively as the MLPIO method can, despite its robustness.

Regarding the performance of the not-fully optimized C++ software running on the Nvidia Jetson. The framerate for a full pipeline implementation, from acquisition to laser line coordinates, was 10–15 FPS for quarter resolution, and 2–4 FPS for full-resolution demosaicing. Depending on the optimization, laser line extraction method is chosen.

Based on the results under the given conditions and discussion, the preferred methods are summarized in Table IV. The experimental results support the scope of this article where we consider a realistic industrial application when scanning has to be done at 0° tilt to maintain the precision of the scanned data. However, small deviations from 0° tilt can occur, especially when scanning complex geometries. Therefore, tilt angles up to 10° are reasonable to take into consideration in the implementation of an industrial scanning operation. In that perspective, Table IV gives

an overview of suggested methods for realistic industrial applications.

### VIII. CONCLUSION

In this article, a novel polarization vision system and its pipeline were presented. In addition, two methods for demosaicing, two methods for optimization, and two methods for laser line extraction were developed for a polarization CIS. The CPFA demosaicing methods could output either one-quarter or full-resolution 12-channel images, avoiding computational expensive operations. The proposed irradiance-based MLPIO method was able to efficiently filter the diffuse component of the reflections of the laser. Meanwhile, the proposed polarization-based PIO method is a completely novel approach. This method facilitates the development of a laser line scanner system based purely on polarization, which is an advantage for the application cases where capturing a high PSNR laser image with a CIS is not possible (i.e., strong ambient light or weak laser), and/or the color capability of the CIS is desired (i.e., no bandpass filter is used). And finally, the polarized FIR-COG and polarized FIR-Peak were the proposed methods to extract the laser line coordinates from the optimized polarization images with subpixel precision.

The proposed system was tested by scanning a blue laser line projected onto two aluminum alloy 6082 plates, under two different light conditions, and in six different orientations. The test results suggested that the performance of the polarization CIS is better compared to the nonpolarized CIS, although similar in the less challenging test case where no interreflections are present and the PSNR of the laser image is high. In terms of the optimization methods, the MLPIO method performed better under standard ambient light conditions (PSNR of the laser image is high), due to its ability to efficiently filter the diffuse reflections noise. Whereas the PIO method performed better under strong ambient light conditions (PSNR of the laser image of the other methods is low), due to its ability to efficiently filter the nonpolarized ambient light noise. In terms of the laser line extraction methods, the polarized FIR-COG performed better, when no interreflections noise was present. Whereas the polarized FIR-Peak performed better when the interreflections noise was present.

From an industrial perspective, the presented work can be used as the foundation for designing a pipeline running on the low-level firmware of an industrial laser triangulation system based on polarization sensing.

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